

Notice of References Cited	Application/Control No. 10/538,825		Applicant(s)/Patent Under Reexamination YE, CHUN	
	Examiner Derek S. Chapel		Art Unit 2872	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,129,357	12-1978	Frosch et al.	359/497
*	B	US-2001/0010593	08-2001	Terahara et al.	359/484
*	C	US-2004/0001255	01-2004	Fratello, Vincent J.	359/484
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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